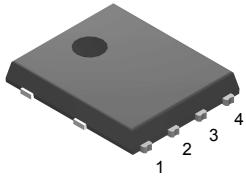
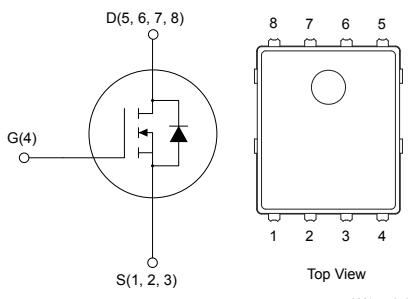


Automotive N-channel 100 V, 4.6 mΩ max., 125 A STripFET F8 Power MOSFET in a PowerFLAT 5x6 package

Features



PowerFLAT 5x6



AM15540v3

Order code	V _{DS}	R _{DS(on)} max.	I _D
STL125N10F8AG	100 V	4.6 mΩ	125 A



- AEC-Q101 qualified
- MSL1 grade
- 175 °C maximum operating junction temperature
- 100% avalanche tested
- Low gate charge Q_g
- Wettable flank package

Applications

- Automotive motor control
- Electro mobility

Description

The **STL125N10F8AG** is a 100 V N-channel enhancement mode Power MOSFET designed in STripFET F8 technology featuring an enhanced trench gate structure.

It ensures a state-of-the-art of figure of merit for very low on-state resistance while reducing internal capacitances and gate charge for faster and more efficient switching.



Product status link	
STL125N10F8AG	

Product summary	
Order code	STL125N10F8AG
Marking ⁽¹⁾	125N10F8
Package	PowerFLAT 5x6
Packing	Tape and reel

1. For engineering samples marking, see Section 3.3: PowerFLAT 5x6 marking information.

1 Electrical ratings

Table 1. Absolute maximum ratings (at $T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	100	V
V_{GS}	Gate-source voltage	± 20	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$ ⁽³⁾	125	A
	Drain current (continuous) at $T_C = 100^\circ\text{C}$ ⁽³⁾	88	
	Drain current (continuous) at $T_C = 25^\circ\text{C}$ ⁽²⁾	120	
$I_{DM}^{(1)(3)(4)}$	Drain current (pulsed), $t_P = 10 \mu\text{s}$	500	A
P_{TOT}	Total power dissipation at $T_C = 25^\circ\text{C}$	150	W
I_{AS}	Single pulse avalanche current (pulse width limited by maximum junction temperature)	60	A
E_{AS}	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$, $I_D = 60 \text{ A}$, $R_G = 25 \Omega$)	140	mJ
T_J	Operating junction temperature range	-55 to 175	$^\circ\text{C}$
T_{stg}	Storage temperature range		$^\circ\text{C}$

1. Specified by design, not tested in production.
2. This current value is limited by package.
3. This is the theoretical current value only related to the silicon.
4. Pulse width is limited by safe operating area.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thJA}^{(1)}$	Thermal resistance, junction-to-ambient (on 2s2p FR-4 board vertical in still area)	16.2	$^\circ\text{C}/\text{W}$
R_{thJC}	Thermal resistance, junction-to-case	1.0	$^\circ\text{C}/\text{W}$

1. Defined according to JEDEC standards (JESD51-5, -7).

2 Electrical characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified.

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	100			V
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^\circ\text{C}^{(1)}$			100	
I_{GSS}	Gate-body leakage current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2		4	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 60 \text{ A}$		3.6	4.6	$\text{m}\Omega$

1. Specified by design and evaluated by characterization, not tested in production.

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}^{(1)}$	Input capacitance		-	3600	-	pF
$C_{oss}^{(1)}$	Output capacitance	$V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$	-	840	-	pF
$C_{rss}^{(1)}$	Reverse transfer capacitance		-	25	-	pF
$Q_g^{(1)}$	Total gate charge		-	56	-	nC
$Q_{gs}^{(1)}$	Gate-source charge	$V_{DD} = 50 \text{ V}, I_D = 120 \text{ A}, V_{GS} = 0 \text{ to } 10 \text{ V}$	-	17	-	nC
$Q_{gd}^{(1)}$	Gate-drain charge		-	15	-	nC

1. Specified by design and evaluated by characterization, not tested in production.

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}^{(1)}$	Turn-on delay time		-	17	-	ns
$t_r^{(1)}$	Rise time	$V_{DD} = 50 \text{ V}, I_D = 60 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	16	-	ns
$t_{d(off)}^{(1)}$	Turn-off delay time		-	41	-	ns
$t_f^{(1)}$	Fall time		-	17	-	ns

1. Specified by design and evaluated by characterization, not tested in production.

Table 6. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)(2)}$	Forward on current (continuous)	$T_C = 25^\circ C$	-		100	A
V_{SD}	Forward on voltage	$I_{SD} = 60 A, V_{GS} = 0 V$	-		1.2	V
$t_{rr}^{(1)}$	Reverse recovery time	$I_D = 60 A, dI/dt = 100 A/\mu s, V_{DD} = 80 V$	-	67		ns
$Q_{rr}^{(1)}$	Reverse recovery charge		-	127		nC
$I_{RRM}^{(1)}$	Reverse recovery current		-	3.7		A

1. Specified by design and evaluated by characterization, not tested in production.

2. This is the theoretical current value only related to the silicon.

2.1 Electrical characteristics (curves)

Figure 1. Total power dissipation

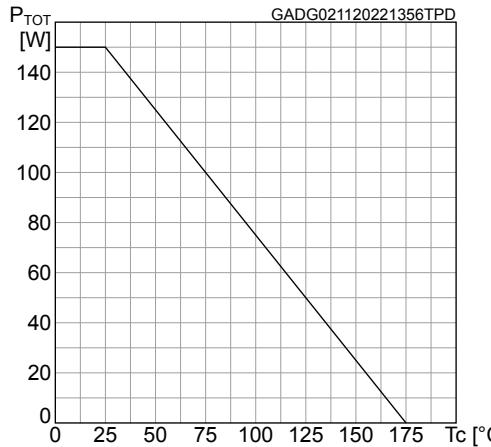


Figure 2. Drain current vs case temperature

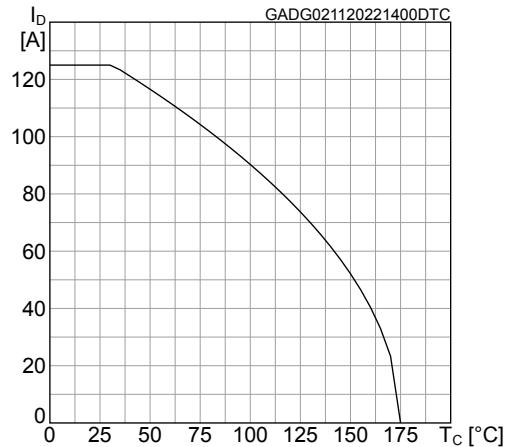


Figure 3. Safe operating area

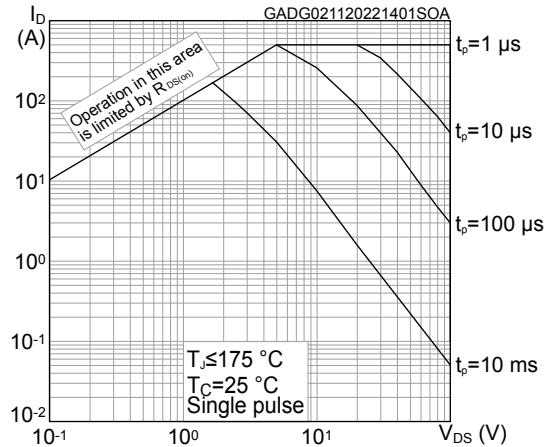


Figure 4. Normalized transient thermal impedance

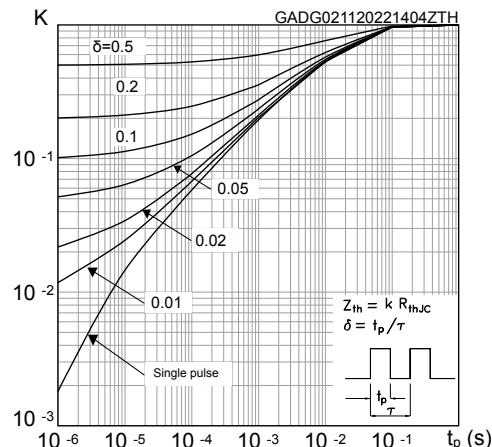


Figure 5. Typical output characteristics

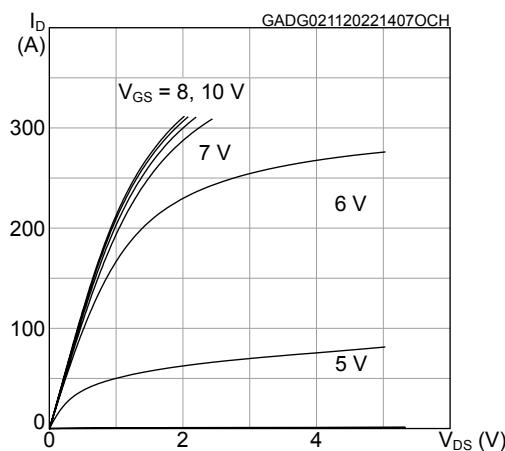


Figure 6. Typical transfer characteristics

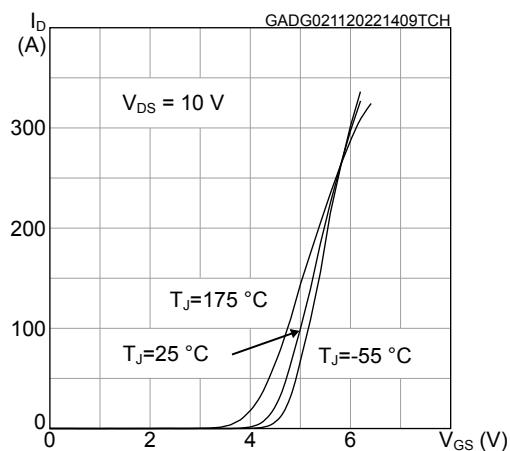


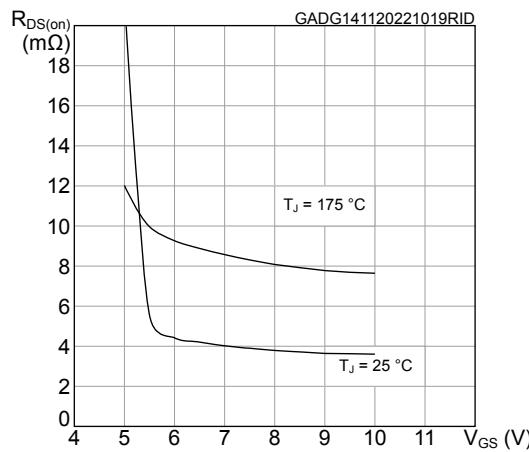
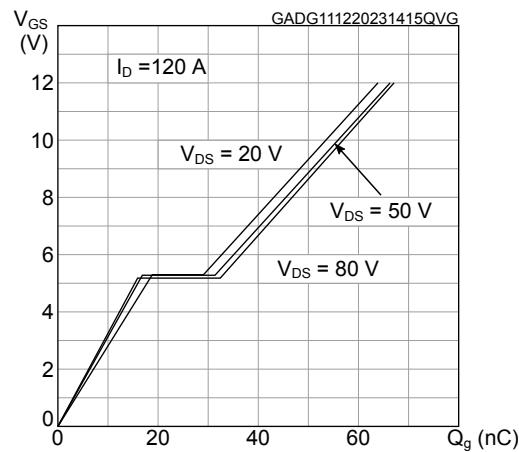
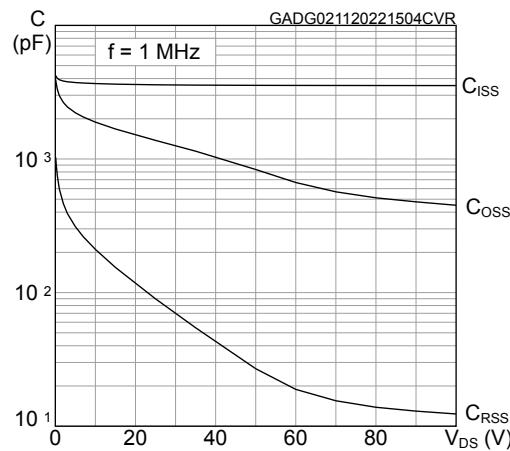
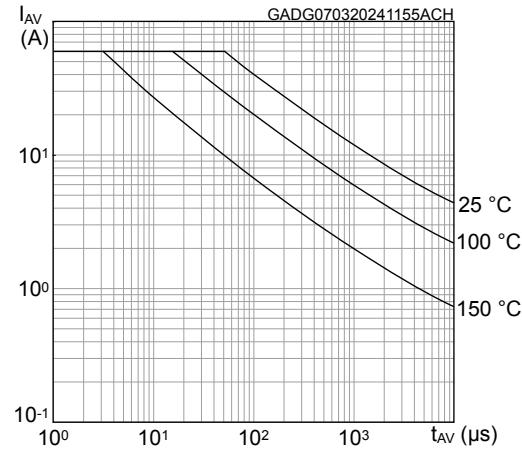
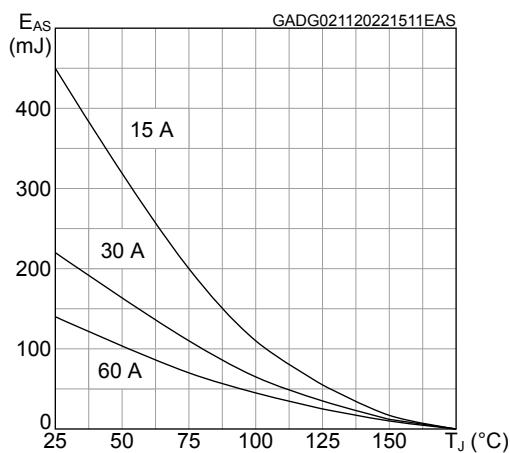
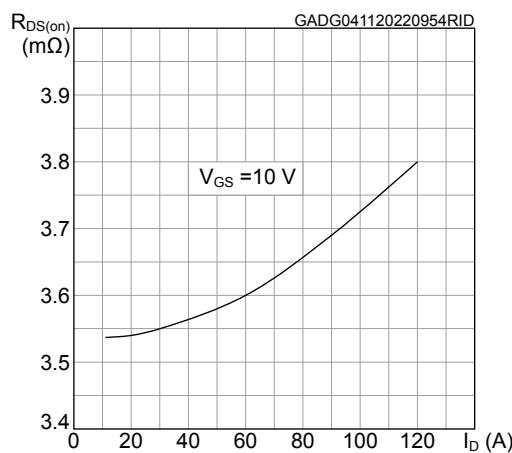
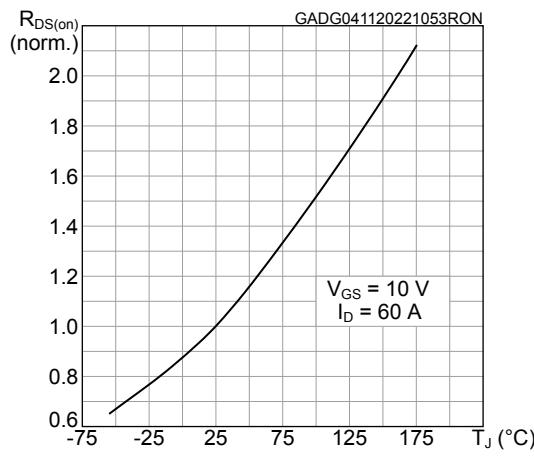
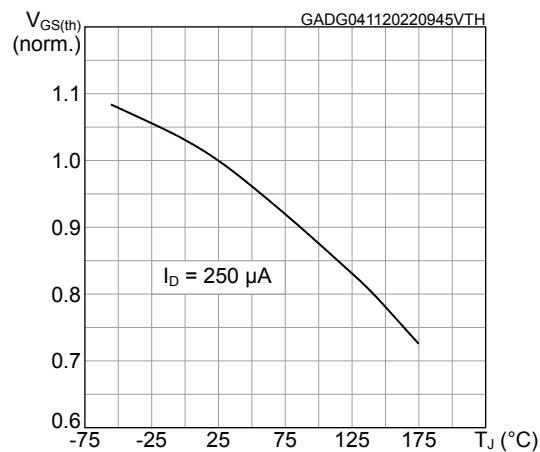
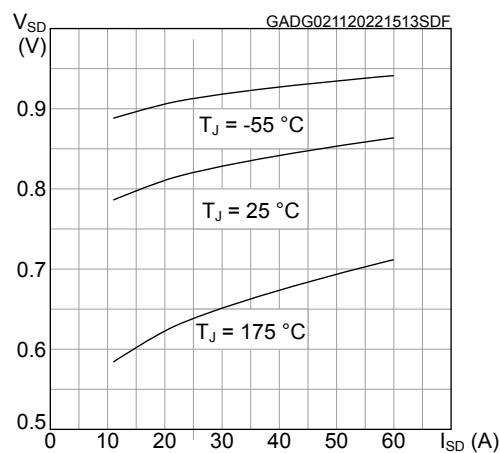
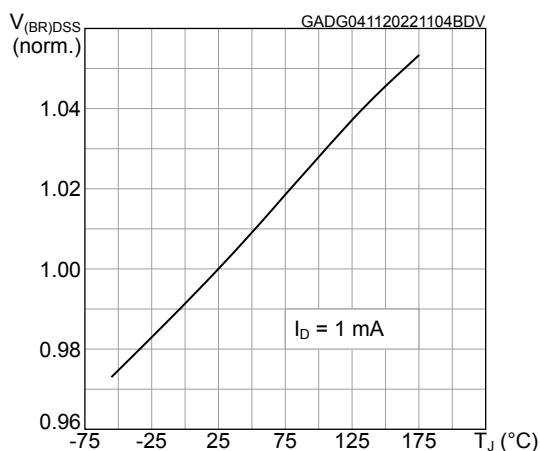
Figure 7. Typical on-resistance vs gate-source voltage

Figure 8. Typical gate charge characteristics

Figure 9. Typical capacitance characteristics

Figure 10. Avalanche characteristics

Figure 11. Avalanche energy

Figure 12. Static drain-source on-resistance


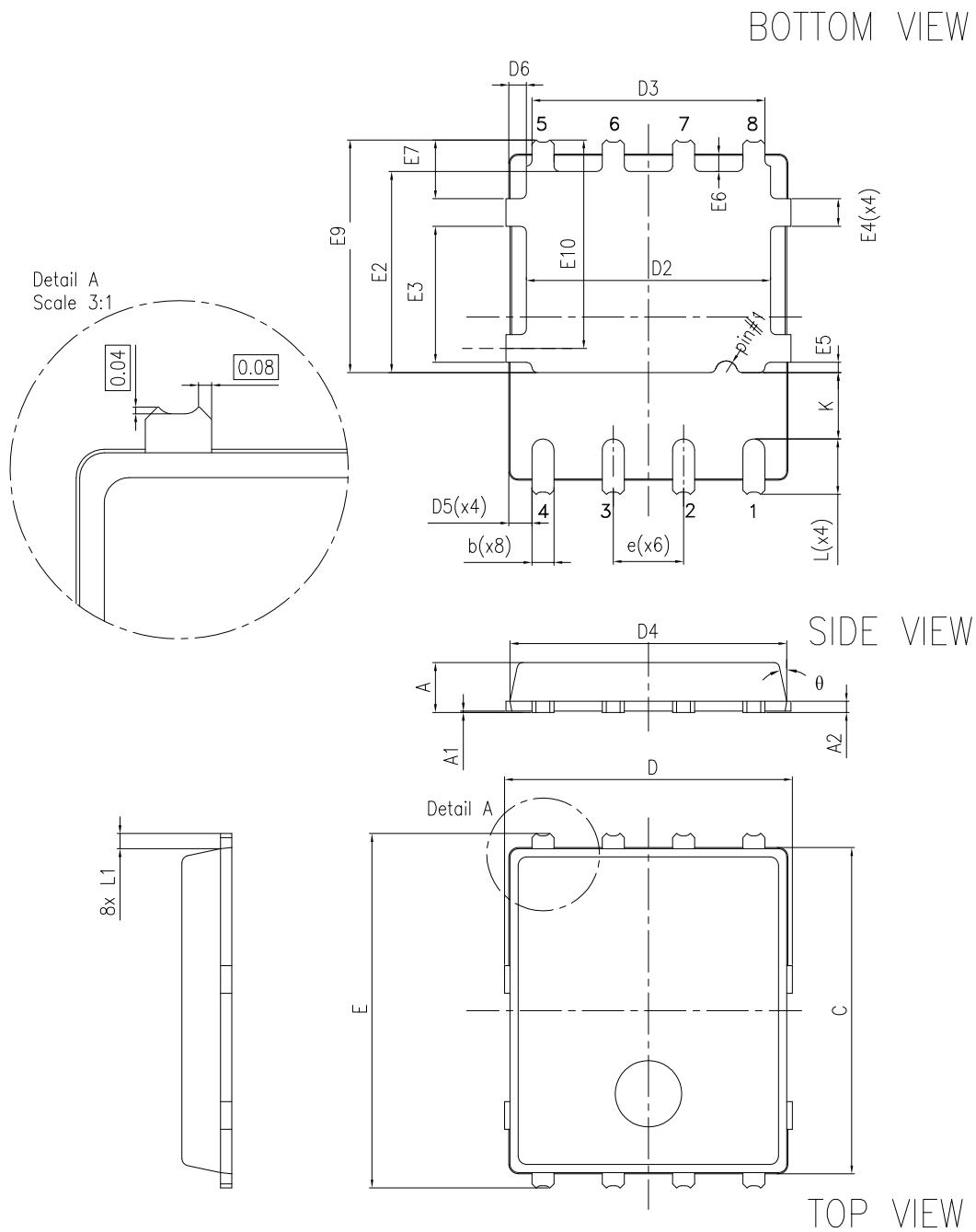
Figure 13. Normalized on-resistance vs temperature

Figure 14. Normalized gate threshold voltage vs temperature

Figure 15. Typical reverse diode forward characteristics

Figure 16. Normalized V_{(BR)DSS} vs temperature


3 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

3.1 PowerFLAT 5x6 WF type C package information

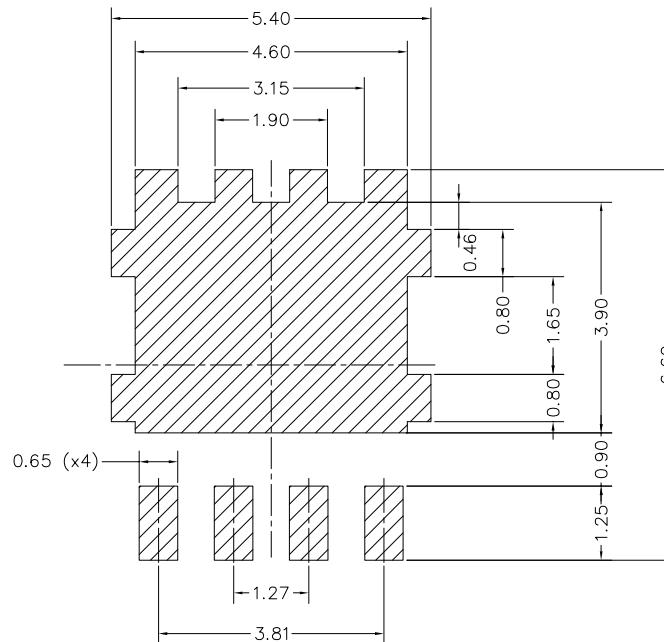
Figure 17. PowerFLAT 5x6 WF type C package outline



8231817_WF_typeC_r23

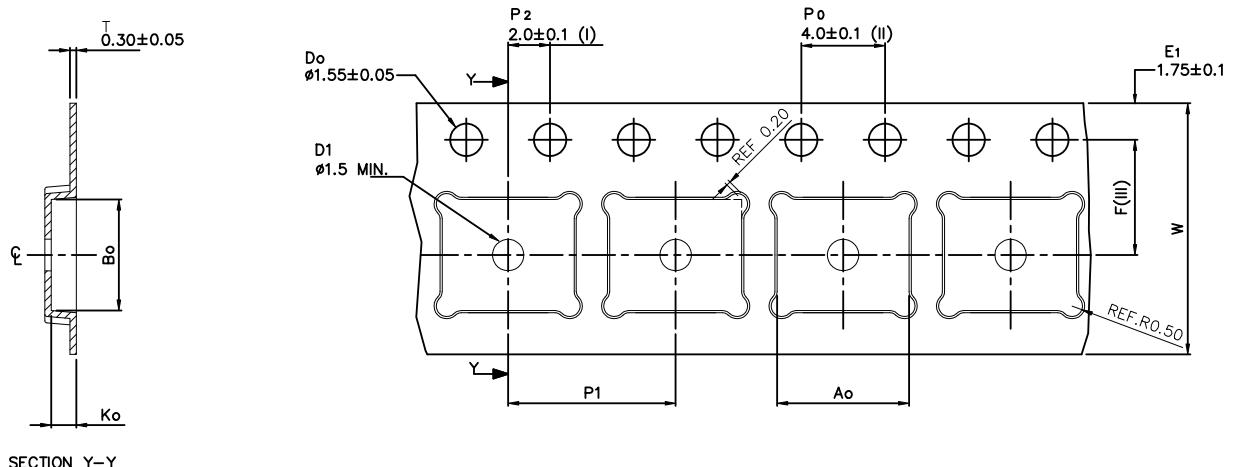
Table 7. PowerFLAT 5x6 WF type C mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.80		1.00
A1	0.00		0.05
A2		0.25	
b	0.30		0.50
C	5.80	6.00	6.10
D	5.00	5.20	5.40
D2	4.15		4.45
D3	4.05	4.20	4.35
D4	4.80	5.00	5.10
D5	0.25	0.40	0.55
D6	0.15	0.30	0.45
e		1.27	
E	6.20	6.40	6.60
E2	3.50		3.70
E3	2.35		2.55
E4	0.40		0.60
E5	0.08		0.28
E6	0.20	0.325	0.45
E7	0.85	1.00	1.15
E9	4.00	4.20	4.40
E10	3.55	3.70	3.85
K	1.05		1.35
L	0.90	1.00	1.10
L1	0.175	0.275	0.375
θ	0°		12°

Figure 18. PowerFLAT 5x6 recommended footprint (dimensions are in mm)


8231817_FOOTPRINT_rev23

3.2 PowerFLAT 5x6 packing information

Figure 19. PowerFLAT 5x6 tape (dimensions are in mm)


A _o	6.30 +/− 0.1
B _o	5.30 +/− 0.1
K _o	1.20 +/− 0.1
F	5.50 +/− 0.1
P ₁	8.00 +/− 0.1
W	12.00 +/− 0.3

(I) Measured from centreline of sprocket hole to centreline of pocket.

(II) Cumulative tolerance of 10 sprocket holes is ±0.20.

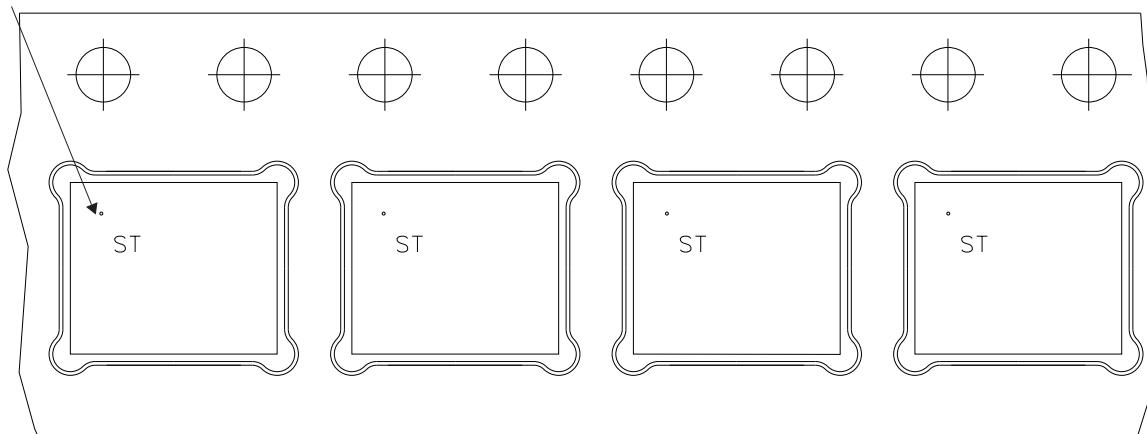
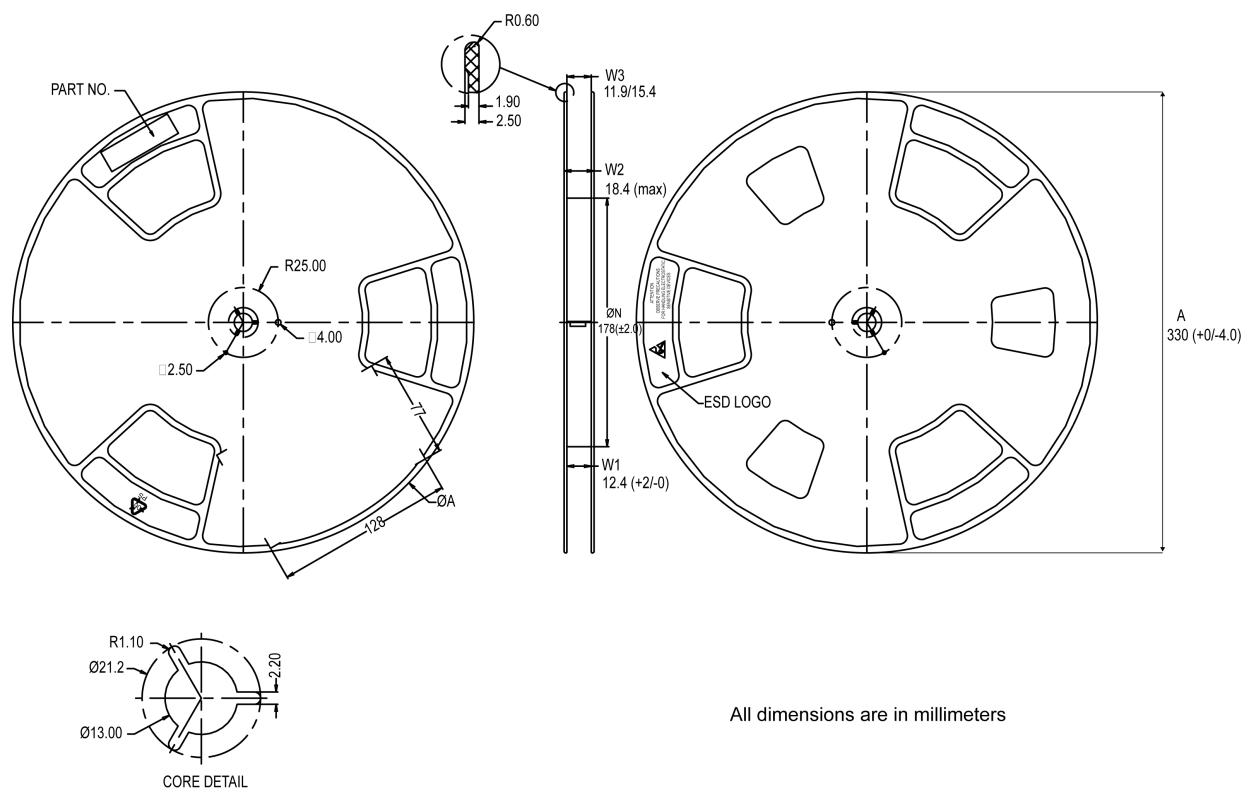
(III) Measured from centreline of sprocket hole to centreline of pocket

Base and bulk quantity 3000 pcs
 All dimensions are in millimeters

8234350_Tape_rev_C

Figure 20. PowerFLAT 5x6 package orientation in carrier tape

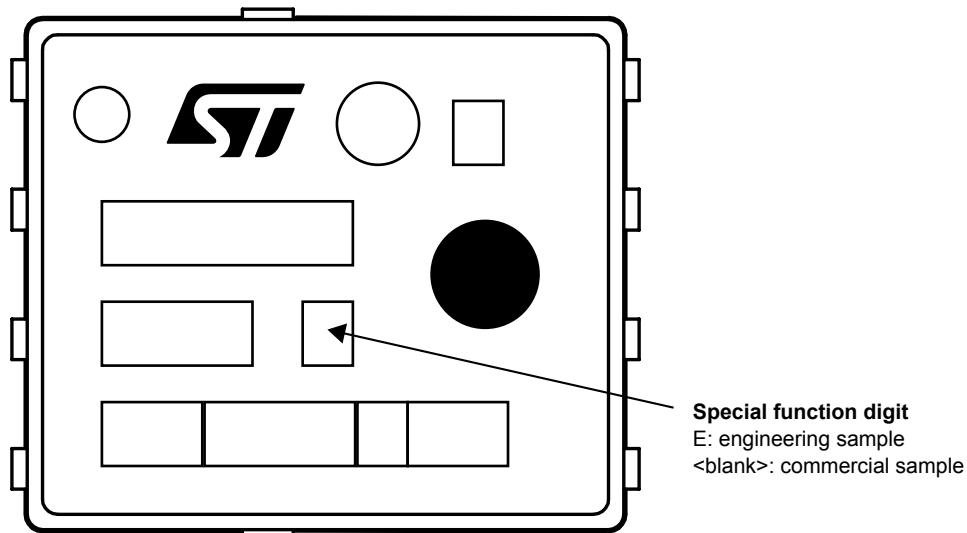
Pin 1 identification

**Figure 21. PowerFLAT 5x6 reel**

8234350_Reel_rev_C

3.3 PowerFLAT 5x6 marking information

Figure 22. PowerFLAT 5x6 marking information



Note: *Engineering Samples: these samples can be clearly identified by a dedicated special symbol in the marking of each unit. These samples are intended to be used for electrical compatibility evaluation only; usage for any other purpose may be agreed only upon written authorization by ST. ST is not liable for any customer usage in production and/or in reliability qualification trials.*

Commercial Samples: fully qualified parts from ST standard production with no usage restrictions.

Revision history

Table 8. Document revision history

Date	Revision	Changes
11-Dec-2023	1	First release.
11-Mar-2024	2	Updated <i>Figure 10. Avalanche characteristics</i> .
06-May-2024	3	Updated <i>Section PowerFLAT 5x6 single island WF cover image</i> .
10-May-2024	4	Updated <i>Section Internal schematic</i> .

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